Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/568,326	NAESJE, KJETIL
Examiner	Art Unit
Stanhan M. Hannarla	3753

SEARCHED				
Class	Subclass	Date	Examiner	
137	494 x 907 *	1/08	GUA	
239	32 33 *			
220	714×			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEA)		")
	DATE	EXMR
EAST	1/08	SIII
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